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Team Nexperia

PHB45NQ15T

N-channel TrenchMOS standard level FET

Rev. 02 — 2 February 2009

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Higher operating power due to low thermal resistance
- Low conduction losses due to low on-state resistance
- Simple gate drive required due to low gate charge
- Suitable for high frequency applications due to fast switching characteristics

1.3 Applications

AC-to-DC secondary side rectification

■ DC-to-DC converters

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$	-	-	150	V
I_D	drain current	$T_{mb} = 25 ^{\circ}\text{C}; V_{GS} = 10 \text{V};$ see <u>Figure 3</u> ; see <u>Figure 1</u>	-	-	45.1	Α
Dynamic	characteristics					
Q_{GD}	gate-drain charge	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ $V_{DS} = 75 \text{ V}; T_j = 25 \text{ °C};$ see Figure 11	-	10.3	-	nC
Static ch	aracteristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 20 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \underline{\text{Figure 9}};$ $\text{see } \underline{\text{Figure 10}}$	-	34	42	mΩ



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	D	drain	mb	D
3	S	source		$G \longrightarrow \overline{A}$
mb			1 3	mbb076 S
			SOT404 (D2PAK)	

3. Ordering information

Table 3. Ordering information

Type number	Package						
	Name	Description	Version				
PHB45NQ15T	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404				

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$	-	150	V
V_{DGR}	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	150	V
V_{GS}	gate-source voltage		-20	20	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 100 °C; see <u>Figure 1</u>	-	31.9	Α
		V _{GS} = 10 V; T _{mb} = 25 °C; see <u>Figure 3</u> ; see <u>Figure 1</u>	-	45.1	Α
I_{DM}	peak drain current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$; see Figure 3	-	90.2	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	230	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Source-di	ain diode				
I _S	source current	T _{mb} = 25 °C	-	45.1	Α
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$	-	90.2	Α
Avalanch	e ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 19.1 A; V_{sup} ≤ 150 V; R_{GS} = 50 Ω ; t_p = 0.1 ms; unclamped	-	180	mJ

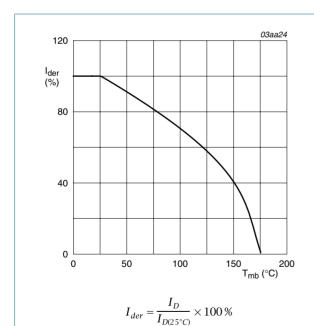
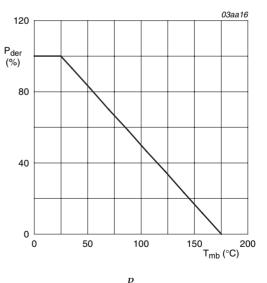


Fig 1. Normalized continuous drain current as a function of mounting base temperature



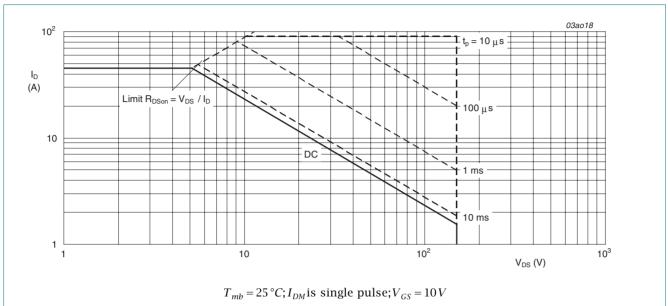
 $P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$

Fig 2. Normalized total power dissipation as a function of mounting base temperature

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Safe operating area; continuous and peak drain currents as a function of drain-source voltage Fig 3.

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Thermal characteristics

Thermal characteristics Table 5.

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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	mounted on a printed-circuit board; minimum footprint; vertical in still air	-	50	-	K/W
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	-	0.65	K/W

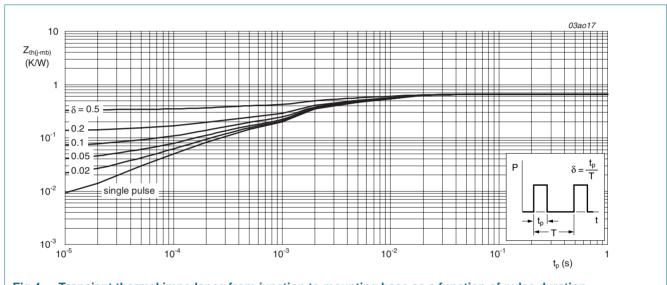


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

Table 0.	Onaracteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$	135	-	-	V
	breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	150	-	-	V
$V_{GS(th)}$	V _{GS(th)} gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS} ; T_j = -55 °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	-	-	4.4	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 25$ °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	2	3	4	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 175$ °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	1	-	-	V
I _{DSS}	drain leakage current	$V_{DS} = 120 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	1	μΑ
		V _{DS} = 120 V; V _{GS} = 0 V; T _j = 175 °C	-	-	100	μΑ
I _{GSS}	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
R _{DSon} drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 20 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see Figure 9; see Figure 10	-	91.8	113.4	mΩ	
		$V_{GS} = 10 \text{ V}; I_D = 20 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see Figure 9; see Figure 10	-	34	42	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 75 \text{ V}; V_{GS} = 10 \text{ V};$	-	32	-	nC
Q_{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 11</u>	-	5.6	-	nC
Q_{GD}	gate-drain charge		-	10.3	-	nC
C _{iss}	input capacitance	$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	1770	-	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 12</u>	-	290	-	pF
C _{rss}	reverse transfer		-	90	-	pF
	capacitance					
d(on)	capacitance turn-on delay time	$V_{DS} = 75 \text{ V}; R_L = 3 \Omega; V_{GS} = 10 \text{ V};$	-	11.5	-	ns
. ,	•	$V_{DS} = 75 \text{ V}; \text{ R}_{L} = 3 \Omega; \text{ V}_{GS} = 10 \text{ V};$ $R_{G(ext)} = 5.6 \Omega; \text{ T}_{j} = 25 \text{ °C}$	-	11.5 22	-	ns ns
t _{d(on)} t _r	turn-on delay time					
d(off)	turn-on delay time			22	-	ns
t _r t _{d(off)} t _f	turn-on delay time rise time turn-off delay time		- - -	22 42	-	ns ns
t _r t _{d(off)} t _f	turn-on delay time rise time turn-off delay time fall time		- - -	22 42	-	ns ns
tr d(off) tr Source-d	turn-on delay time rise time turn-off delay time fall time rain diode	$R_{G(ext)} = 5.6 \Omega$; $T_j = 25 °C$ $I_S = 25 A$; $V_{GS} = 0 V$; $T_j = 25 °C$;	- - - -	22 42 31	-	ns ns ns

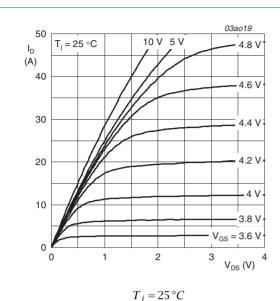
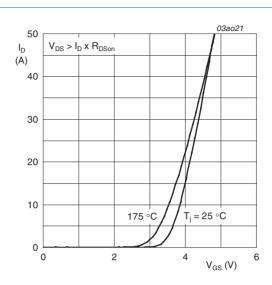


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_j = 25 \,^{\circ}C \,\text{and} \, 175 \,^{\circ}C; V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values

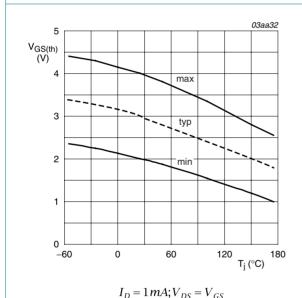


Fig 7. Gate-source threshold voltage as a function of junction temperature

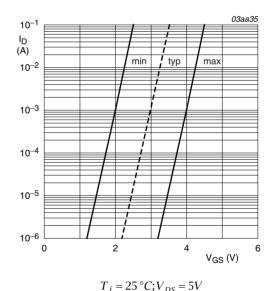
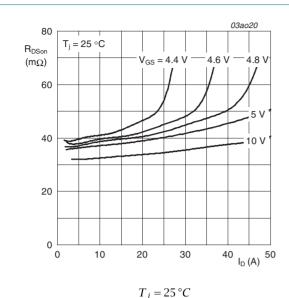
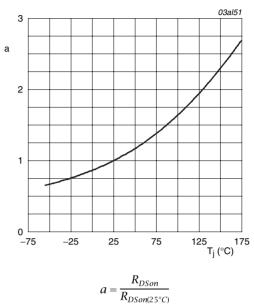


Fig 8. Sub-threshold drain current as a function of gate-source voltage



Drain-source on-state resistance as a function of drain current; typical values



$$a = \frac{25000}{R_{DSon(25^{\circ}C)}}$$

Fig 10. Normalized drain-source on-state resistance factor as a function of junction temperature

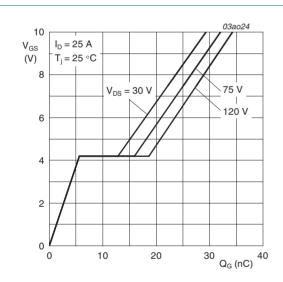
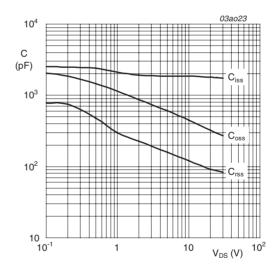


Fig 11. Gate-source voltage as a function of gate charge; typical values

 $I_D = 25A; V_{DD} = 30V, 75V \text{ and } 120V$



 $V_{GS} = 0V; f = 1MHz$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

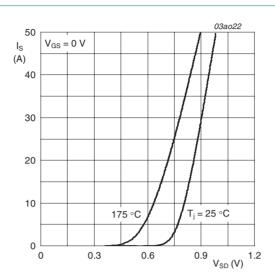
Fig 9.

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 $T_j = 25 \,^{\circ}C \, \text{and} \, 175 \,^{\circ}C; V_{GS} = 0 \, V$

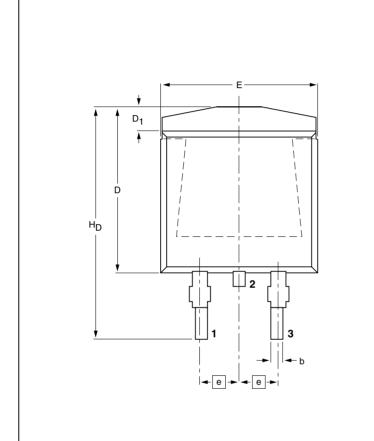
Fig 13. Source current as a function of source-drain voltage; typical values

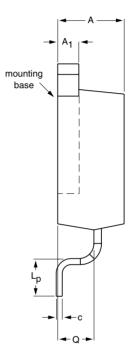
7. Package outline

Plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)

SOT404

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DIMENSIONS (mm are the original dimensions)

UNIT	A	A ₁	b	С	D max.	D ₁	E	e	L _p	Н _D	Q
mm	4.50 4.10	1.40 1.27	0.85 0.60	0.64 0.46	11	1.60 1.20	10.30 9.70	2.54	2.90 2.10	15.80 14.80	2.60 2.20

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT404						05-02-11 06-03-16

Fig 14. Package outline SOT404 (D2PAK)



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Revision history

Table 7. **Revision history**

Product data sheet

Document ID	Release date	Data sheet status	Change notice	Supersedes		
PHB45NQ15T_2	20090202	Product data sheet	-	PHP_PHB45NQ15T_1		
Modifications:	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. Legal texts have been adapted to the new company name where appropriate. 					
	Legal lexis	nave been adapted to the	e new company name w	пете арргорнате.		
PHP_PHB45NQ15T_1 (9397 750 14012)	20041108	Product data sheet	-	-		

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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PHB45NQ15T

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